# New Jersey Semi-Conductor Products, Inc.

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## **IRF430**

# 4.5A, 500V, 1.500 Ohm, N-Channel Power MOSFET

This N-Channel enhancement mode silicon gate power field effect transistor is an advanced power MOSFET designed, tested, and guaranteed to withstand a specified level of energy in the breakdown avalanche mode of operation. All of these power MOSFETs are designed for applications such as switching regulators, switching convertors, motor drivers, relay drivers, and drivers for high power bipolar switching transistors requiring high speed and low gate drive power. These types can be operated directly from integrated circuits.

### Features

- 4.5A, 500V
- r<sub>DS(ON)</sub> = 1.500Ω
- · Single Pulse Avalanche Energy Rated
- · SOA is Power Dissipation Limited
- Nanosecond Switching Speeds
- Linear Transfer Characteristics
- High Input Impedance

## Ordering Information

PART NUMBER	PACKAGE	BRAND
IRF430	TO-204AA	IRF430

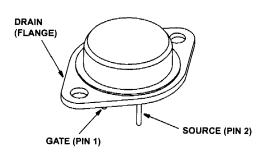
NOTE: When ordering, use the entire part number.

## Symbol



### Packaging

#### JEDEC TO-204AA



NJ Semi-Conductors reserves the right to change test conditions, parameter limits and package dimensions without notice. Information furnished by NJ Semi-Conductors is believed to be both accurate and reliable at the time of going to press. However, NJ Semi-Conductors assumes no responsibility for any errors or omissions discovered in its use. NJ Semi-Conductors encourages customers to verify that datasheets are current before placing orders.

**Quality Semi-Conductors** 

# **Absolute Maximum Ratings** $T_C = 25^{\circ}C$ , Unless Otherwise Specified

	IRF430	UNIT\$
Drain to Source Breakdown Voltage (Note 1)	500	V
Drain to Gate Voltage (R <sub>GS</sub> = 20kΩ) (Note 1)	500	V
Continuous Drain Current	4.5	Α
$T_C = 100^{\circ}C$	3.0	Α
Pulsed Drain Current (Note 3)	18	Α
Gate to Source Voltage	±20	V
Maximum Power Dissipation	75	W
Dissipation Derating Factor	0.6	W/°C
Single Pulse Avalanche Energy Rating (Note 4)	300	mJ
Operating and Storage Temperature	-55 to 150	°C
Maximum Temperature for Soldering		
Leads at 0.063in (1.6mm) from Case for 10s	300	°C
Package Body for 10s, See Techbrief 334	260	°C

CAUTION: Stresses above those listed in "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress only rating and operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied.

#### NOTE:

1.  $T_J = 25^{\circ}C$  to  $125^{\circ}C$ .

# **Electrical Specifications** $T_C = 25^{\circ}C$ , Unless Otherwise Specified

PARAMETER	SYMBOL	TEST CONDITIONS		MIN	TYP	MAX	UNITS
Drain to Source Breakdown Voltage	BV <sub>DSS</sub>	I <sub>D</sub> = 250μA, V <sub>GS</sub> = 0V (Figure 10)		500	-	-	٧
Gate Threshold Voltage	V <sub>GS(TH)</sub>	V <sub>GS</sub> = V <sub>DS</sub> , I <sub>D</sub> = 250μA		2.0	-	4.0	٧
Gate to Source Leakage Current	IGSS	V <sub>GS</sub> = ±20V				±100	nA
Zero Gate Voltage Drain Current	IDSS	V <sub>DS</sub> = Rated BV <sub>DSS</sub> , V <sub>GS</sub> = 0V V <sub>DS</sub> = 0.8 x Rated BV <sub>DSS</sub> , V <sub>GS</sub> = 0V, T <sub>J</sub> = 125°C		-	-	25	μА
					-	250	μΑ
On-State Drain Current (Note 2)	I <sub>D(ON)</sub>	V <sub>DS</sub> > I <sub>D(ON)</sub> × r <sub>DS(ON)MAX</sub> , V <sub>GS</sub> = 10V (Figure 7)		4.5	-	-	Α
Drain to Source On Resistance (Note 2)	<sup>r</sup> DS(ON)	I <sub>D</sub> = 2.5A, V <sub>GS</sub> = 10V (Fig	jures 8, 9)	-	1.3	1.500	Ω
Forward Transconductance (Note 2)	9fs	V <sub>DS</sub> ≥ 10V, I <sub>D</sub> = 2.7A (Fig	ure 12)	2.5	3.2	-	S
Turn-On Delay Time	t <sub>d(ON)</sub>	$\begin{split} &V_{DD} = 250 \text{V, I}_D \approx 4.5 \text{A, R}_G = 12 \Omega, \text{ R}_L = 50 \Omega \\ &\text{(Figures 17, 18) MOSFET Switching Times are} \\ &\text{Essentially Independent of Operating} \\ &\text{Temperature} \end{split}$			11	17	ns
Rise Time	t <sub>r</sub>			-	15	23	ns
Turn-Off Delay Time	t <sub>d</sub> (OFF)			-	35	53	ns
Fall Time	t <sub>f</sub>				15	23	ns
Total Gate Charge (Gate to Source + Gate to Drain)	Q <sub>g(TOT)</sub>	$V_{GS}$ = 10V, $I_D \approx$ 6.0A, $V_{DS}$ = 0.8 x Rated BV <sub>DSS</sub> , $I_{g(REF)}$ = 1.5mA (Figures 14, 19, 20) Gate Charge is Essentially Independent of Operating Temperature		-	22	32	nC
Gate to Source Charge	Q <sub>gs</sub>			-	3.5	-	nC
Gate to Drain "Miller" Charge	Q <sub>gd</sub>			-	11	-	nC
Input Capacitance	C <sub>ISS</sub>	V <sub>DS</sub> = 25V, V <sub>GS</sub> = 0V, f = 1MHz (Figure 11)		_	600	-	pF
Output Capacitance	Coss			-	100	-	pF
Reverse Transfer Capacitance	C <sub>RSS</sub>				30	-	рF
Internal Drain Inductance	LD	Measured between the Contact Screw on the Flange that is Closer to Source and Gate Pins and the Center of Die	Modified MOSFET Symbol Showing the Internal Devices Inductances	-	5.0	-	nH
Internal Source Inductance	Ls	Measured from the Source Lead, 6mm (0.25in) from the Flange and the Source Bonding Pad	G L <sub>S</sub> S	-	12.5	-	nH
Thermal Resistance Junction to Case	$R_{\theta JC}$			-	-	0.83	°C/W
Thermal Resistance Junction to Ambient	R <sub>0JA</sub>	Free Air Operation		-	-	30	°C/W

#### **Source to Drain Diode Specifications**

PARAMETER	SYMBOL	TEST CONDITIONS		TYP	MAX	UNITS
Continuous Source to Drain Current	I <sub>SD</sub>	Modified MOSFET Symbol		-	4.5	Α
Pulse Source to Drain Current (Note 3)	I <sub>SDM</sub>	Showing the Integral Reverse P-N Junction Diode		-	18	A
Source to Drain Diode Voltage (Note 2)	V <sub>SD</sub>	T <sub>J</sub> = 25°C, I <sub>SD</sub> = 4.5A, V <sub>GS</sub> = 0V (Figure 13)		-	1.4	V
Reverse Recovery Time	t <sub>rr</sub>	$T_J = 25^{\circ}C$ , $I_{SD} = 4.5A$ , $dI_{SD}/dt = 100A/\mu s$		370	760	ns
Reverse Recovery Charge	Q <sub>RR</sub>	$T_J = 25^{\circ}C$ , $I_{SD} = 4.5A$ , $dI_{SD}/dt = 100A/\mu s$		2	4.3	μС

#### NOTES:

- 2. Pulse test: pulse width  $\leq 300 \mu s$ , duty cycle  $\leq 2\%$ .
- 3. Repetitive rating: pulse width limited by Max junction temperature. See Transient Thermal Impedance curve (Figure 3).
- 4.  $V_{DD}$  = 50V, starting  $T_J$  = 25°C, L = 25mH,  $R_G$  = 25 $\Omega$ , peak  $I_{AS}$  = 4.5A. See Figures 15, 16.

# Typical Performance Curves Unless Otherwise Specified

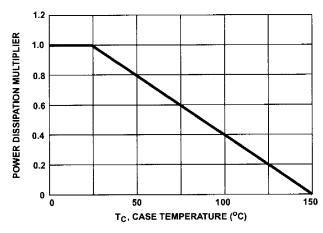


FIGURE 1. NORMALIZED POWER DISSIPATION vs CASE TEMPERATURE

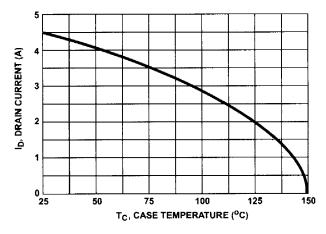


FIGURE 2. MAXIMUM CONTINUOUS DRAIN CURRENT vs CASE TEMPERATURE

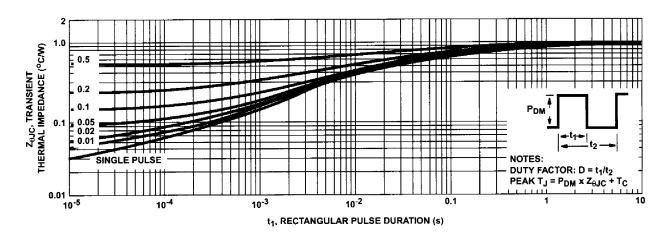


FIGURE 3. MAXIMUM TRANSIENT THERMAL IMPEDANCE